

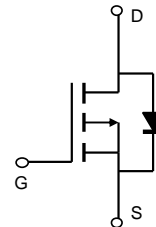
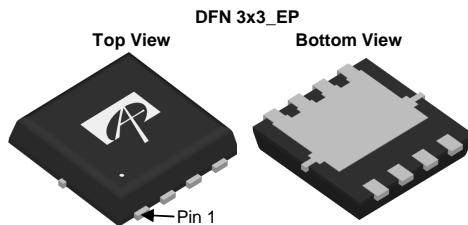
### General Description

The AON7401 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , and ultra-low low gate charge with a 25V gate rating. This device is suitable for use as a load switch or in PWM applications.

### Product Summary

|                                  |                |
|----------------------------------|----------------|
| $V_{DS}$                         | -30V           |
| $I_D$ (at $V_{GS}=-10V$ )        | -29A           |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$ ) | < 14m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=-6V$ )  | < 17m $\Omega$ |

100% UIS Tested  
 100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$       | -30                     | V                |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 25$                | V                |
| Continuous Drain Current               | $I_D$          | $T_C=25^\circ\text{C}$  | -35              |
|  |                | $T_C=100^\circ\text{C}$ | -23              |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | -80                     | A                |
| Continuous Drain Current               | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | -12              |
|  |                | $T_A=70^\circ\text{C}$  | -9.7             |
| Power Dissipation <sup>B</sup>         | $P_D$          | $T_C=25^\circ\text{C}$  | 29               |
|  |                | $T_C=100^\circ\text{C}$ | 12               |
| Power Dissipation <sup>A</sup>         | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 3.1              |
|  |                | $T_A=70^\circ\text{C}$  | 2                |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 30           | 40  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A D</sup> |                 | Steady-State | 60  | 75                 |
| Maximum Junction-to-Lead                   | $R_{\theta JL}$ | 3.5          | 4.2 | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min  | Typ      | Max      | Units |
|-----------------------------|---------------------------------------|---|------|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |      |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V   | -30  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |      |          | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±25V   |      |          | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =-250μA                                     | -1.7 | -2.2     | -3       | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V   | -80  |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-10V, I <sub>D</sub> =-9A<br>T <sub>J</sub> =125°C                         |      | 11<br>16 | 14<br>19 | mΩ    |
|                             |                                       | V <sub>GS</sub> =-6V, I <sub>D</sub> =-7A   |      | 12.9     | 17       |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-9A   |      | 27       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V  |      | -0.7     | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |      |          | -25      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |      |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz  |      | 2060     | 2600     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |   |      | 370      |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |      | 295      |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |      | 2.4      | 3.6      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |      |          |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-9A                           |      | 30       | 39       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |      | 4.6      |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |      | 10       |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =1.6Ω,<br>R <sub>GEN</sub> =3Ω |      | 11       |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |      | 9.4      |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |      | 24       |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |      | 12       |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-9A, di/dt=500A/μs  |      | 14       | 18       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-9A, di/dt=500A/μs  |      | 35       |          | nC    |

A. The value of R<sub>qJA</sub> is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25°C. The Power dissipation PDSM is based on R<sub>qJA</sub> t ≤ 10s value and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150°C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J</sub>(MAX)=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J</sub>(MAX)=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub> =25°C.

D. The R<sub>qJA</sub> is the sum of the thermal impedance from junction to case R<sub>qJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300ms pulses, duty cycle 0.5% max.

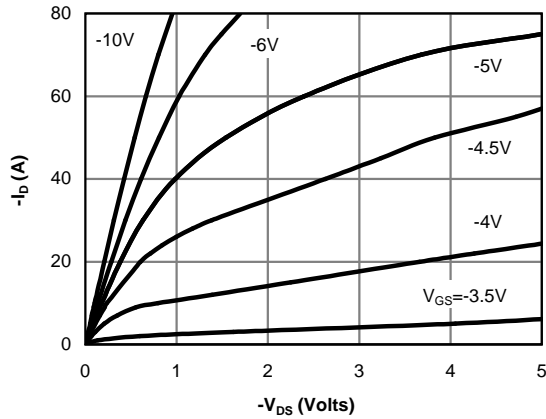
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J</sub>(MAX)=150°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

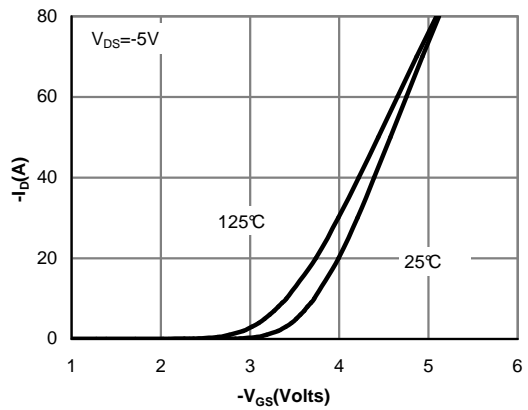
H. These tests are performed with the device mounted on 1 in2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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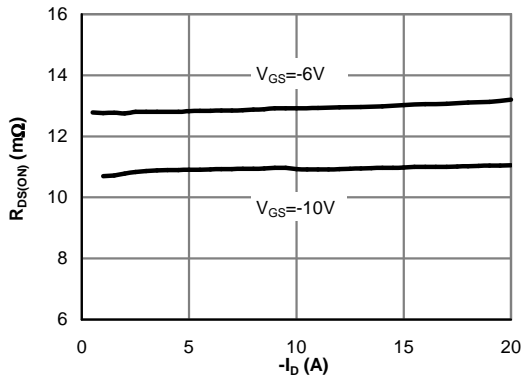
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



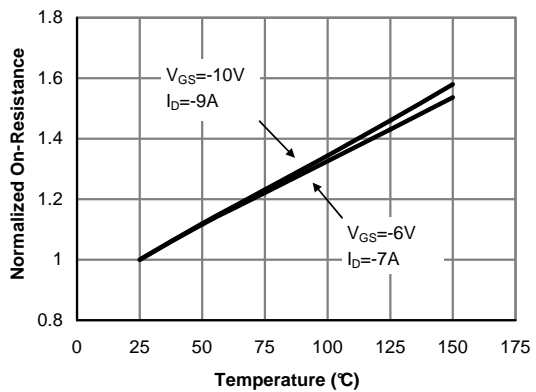
**Figure 1: On-Region Characteristics (Note E)**



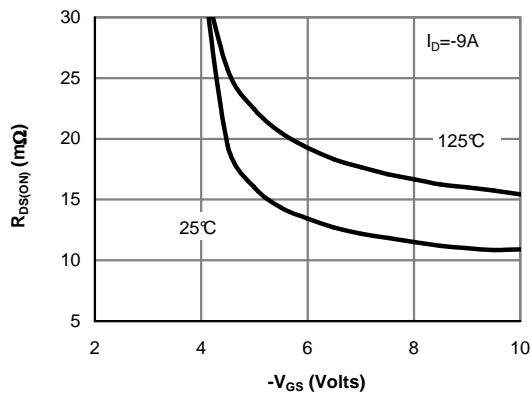
**Figure 2: Transfer Characteristics (Note E)**



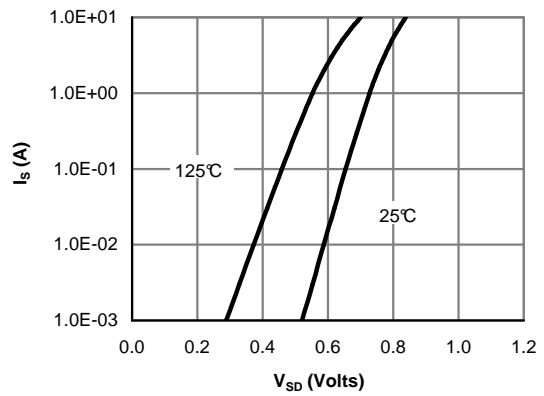
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

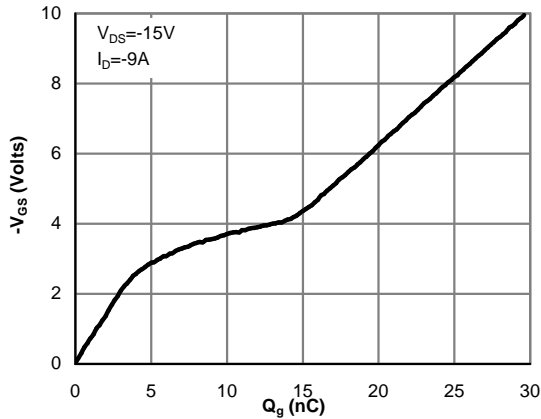


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

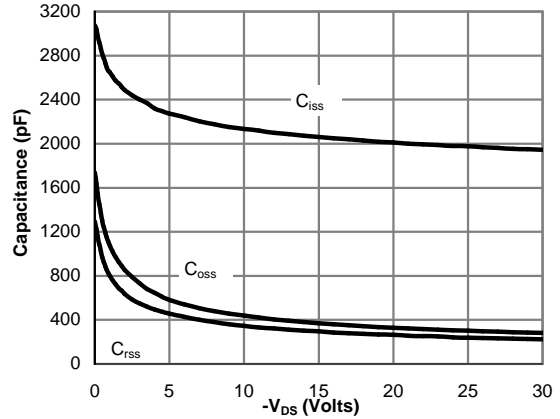


**Figure 6: Body-Diode Characteristics (Note E)**

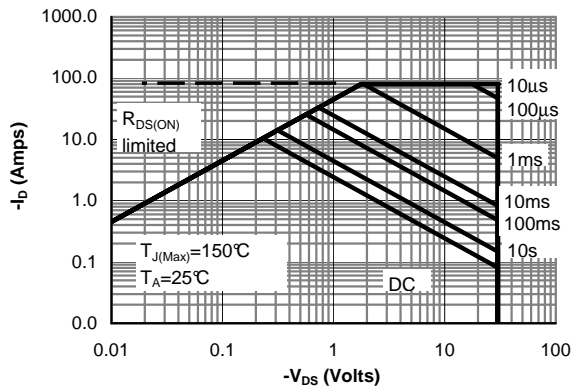
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



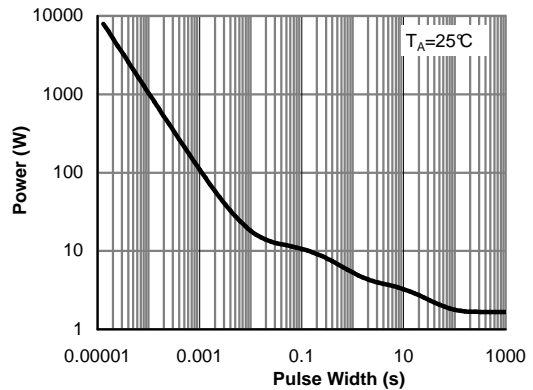
**Figure 7: Gate-Charge Characteristics**



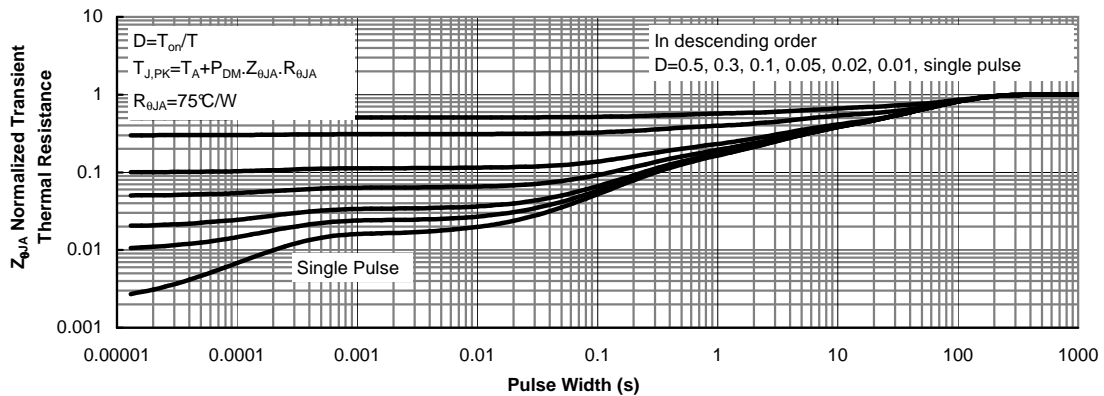
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

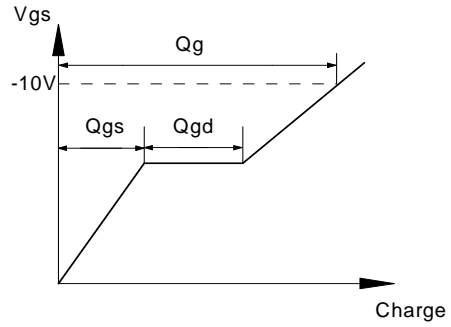
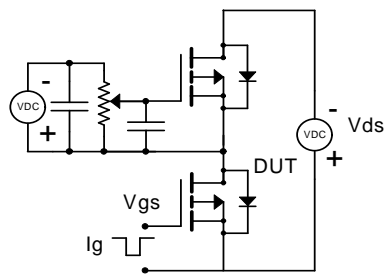


**Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)**

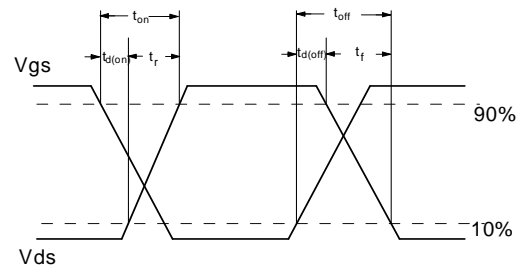
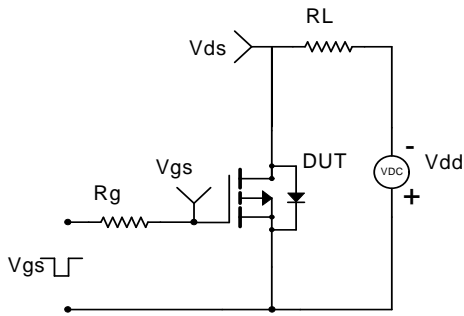


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

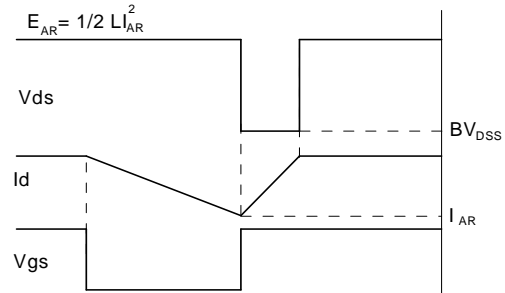
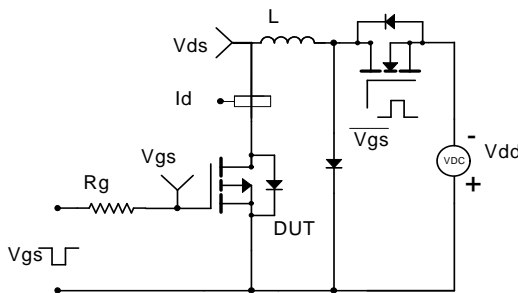
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**

